CLAIMS

- 1. A hydrogen or helium permeation membrane comprising a silicon resin that includes at least one of phenylheptamethylcyclotetrasiloxane and 2, 6-cis-diphenylhexamethylcyclotetrasiloxane.
- 2. The hydrogen or helium permeation membrane according to claim 1, wherein the silicon resin that includes at least one of phenylheptamethylcyclotetrasiloxane and 2, 6-cis-diphenylhexamethylcyclotetrasiloxane contains a metal or oxide particle.
- 3. The hydrogen or helium permeation membrane according to claim 2, wherein the metal or oxide particle comprises a particle or ultrafine particle including at least one of Al, Ti, Si, and Ag, a filler comprising a particle of alumina, titanium oxide, SiO₂, or the like, and an ultrafine particle silica or the like.
- 4. The hydrogen or helium permeation membrane according to any one of claims 1 to 3, wherein the hydrogen permeation membrane is thermally cured at temperature of 200°C to 500°C after being adjusted to a desired viscosity at temperature of 230°C or lower into a procurser.
- 5. The hydrogen or helium permeation membrane according to claim 4, wherein the precursor and the hydrogen permeation membrane are subjected to a vacuum heating process at least once at a temperature lower than or equal to a temperature at which the hydrogen permeation membrane is cured.
- 6. A method for forming a hydrogen or helium permeation membrane comprising the steps of:

causing a metal or oxide particle to be contained in a silicon resin that includes at least one of phenylheptamethylcyclotetrasiloxane and 2, 6-cis-diphenylhexamethylcyclotetrasiloxane, or a silicon resin that includes at least one

of phenylheptamethylcyclotetrasiloxane and 2, 6-cis-diphenylhexamethylcyclotetrasiloxane, and then forming a precursor having a desired viscosity at temperature of 230°C or lower; and

thermally curing the precursor at temperature of 200°C to 500°C.

- 7. The method for forming a hydrogen or helium permeation membrane according to claim 6, wherein the metal or oxide particle comprises a particle or ultrafine particle including at least one of Al, Ti, Si, and Ag, a filler comprising a particle of alumina, titanium oxide, SiO₂, or the like, and an ultrafine particle silica or the like.
- 8. The method for forming a hydrogen or helium permeation membrane according to claim 7, wherein the step of forming the precursor and the hydrogen or helium permeation membrane comprising performing a vacuum thermal process at least once at a temperature lower than or equal to a temperature at which the hydrogen or helium permeation membrane is cured.
- 9. A hydrogen or helium storage membrane comprising a silicon resin that includes at least one of phenylheptamethylcyclotetrasiloxane and 2, 6-cis-diphenylhexamethylcyclotetrasiloxane.
- 10. The hydrogen or helium storage membrane according to claim 9, wherein the silicon resin that includes at least one of phenylheptamethylcyclotetrasiloxane and 2, 6-cis-diphenylhexamethylcyclotetrasiloxane comprises a metal or oxide particle.
- 11. The hydrogen or helium storage membrane according to claim 10, wherein the metal or oxide particle comprises a particle or ultrafine particle including at least one of Al, Ti, Si, and Ag, a filler comprising a particle of alumina, titanium oxide, SiO₂, or the like, and an ultrafine particle silica or the like.

- 12. The hydrogen or helium storage membrane according to claim 10 or 11, wherein the hydrogen storage membrane is thermally cured at temperature of 200°C to 500°C after being adjusted to a desired viscosity at temperature of 230°C or lower into a precursor.
- 13. The hydrogen or helium storage membrane according to claim 10, wherein the precursor and the hydrogen or helium storage membrane is subjected to a vacuum heating process at least once at a temperature lower than or equal to a temperature at which the hydrogen or helium storage membrane is cured.
- 14. A method for forming a hydrogen or helium storage membrane comprising the steps of:

forming a precursor having a desired viscosity at a temperature of 230°C or lower from either a silicon resin that includes at least one of phenylheptamethylcyclotetrasiloxane and 2, 6-cis-diphenylhexamethylcyclotetrasiloxane, or a silicon resin that includes at least one of phenylheptamethylcyclotetrasiloxane and 2, 6-cis-diphenylhexamethylcyclotetrasiloxane, to which resin a metal or oxide particle is contained; and

thermally curing the precursor at temperature of 200°C to 500°C.

- 15. The method for forming a hydrogen or helium storage membrane according to claim 14, wherein the metal or oxide particle comprises a particle or ultrafine particle including at least one of Al, Ti, Si, and Ag, a filler comprising a particle of alumina, titanium oxide, SiO₂, or the like, and an ultrafine particle silica or the like.
- 16. The method for forming a hydrogen or helium storage membrane according to claim 15, wherein the step of forming a hydrogen or helium storage membrane comprises performing a vacuum heating process at least once at a temperature lower than or equal to a temperature at which the hydrogen or helium storage membrane is cured.